

2-OUTPUT VERY LOW POWER PCIE GEN1/2/3 CLOCK GENERATOR
9FGV0241
Description

The 9FGV0241 is a 2-output very low power frequency generator for PCIe Gen 1, 2 and 3 applications with integrated output terminations providing $Z_o=100\Omega$. The device has 2 output enables for clock management and supports 2 different spread spectrum levels in addition to spread off.

Recommended Application

PCIe Gen1/2/3 clock generator

Output Features

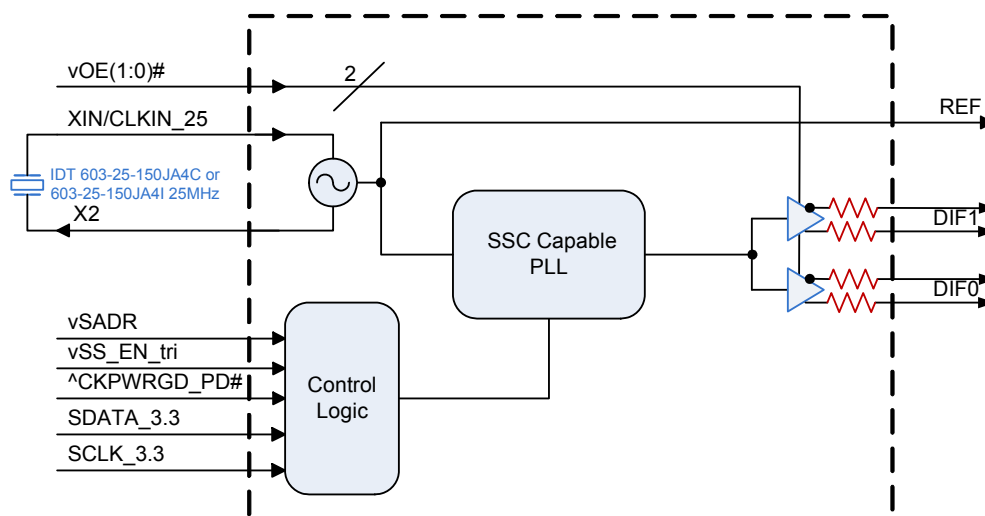
- 2 - 0.7V low-power HCSL-compatible (LP-HCSL) DIF pairs w/ $Z_o=100\Omega$
- 1 - 1.8V LVCMOS REF output w/Wake-On-LAN (WOL) support

Key Specifications

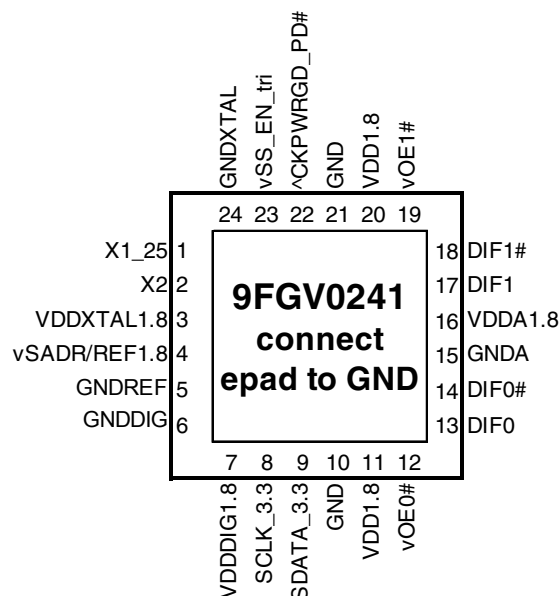
- DIF cycle-to-cycle jitter <50ps
- DIF output-to-output skew <50ps
- DIF phase jitter is PCIe Gen1-2-3 compliant
- REF phase jitter is <1.5ps RMS

Features/Benefits

- Integrated terminations provide 100Ω differential Z_o ; reduced component count and board space
- 1.8V operation; reduced power consumption
- OE# pins; support DIF power management
- LP-HCSL differential clock outputs; reduced power and board space
- Programmable Slew rate for each output; allows tuning for various line lengths
- Programmable output amplitude; allows tuning for various application environments
- DIF outputs blocked until PLL is locked; clean system start-up
- Selectable 0%, -0.25% or -0.5% spread on DIF outputs; reduces EMI
- External 25MHz crystal; supports tight ppm with 0 ppm synthesis error
- Configuration can be accomplished with strapping pins; SMBus interface not required for device control
- 3.3V tolerant SMBus interface works with legacy controllers
- Space saving 24-pin 4x4 mm VFQFPN; minimal board space

Block Diagram


Pin Configuration



24-pin VFQFPN, 4x4 mm, 0.5mm pitch

^ prefix indicates internal 120KOhm pull up resistor
v prefix indicates internal 120KOhm pull down resistor

SMBus Address Selection Table

	SADR	Address	+ Read/Write Bit
State of SADR on first application of CKPWRGD_PD#	0	1101000	x
	1	1101010	x

Power Management Table

CKPWRGD_PD#	SMBus OE bit	DIFx		REF
		True O/P	Comp. O/P	
0	X	Low	Low	Hi-Z ¹
1	1	Running	Running	Running
1	0	Low	Low	Low

1. REF is Hi-Z until the 1st assertion of CKPWRGD_PD# high. After this, when CKPWRGD_PD# is low, REF is Low.

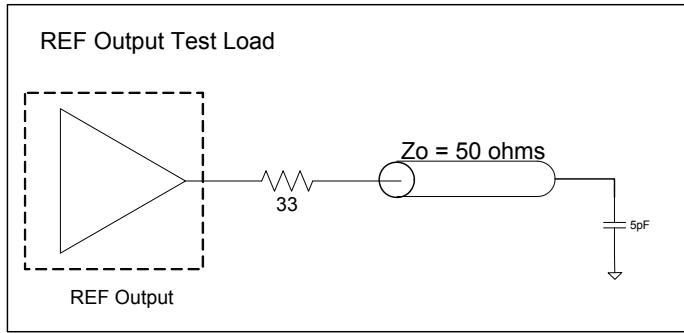
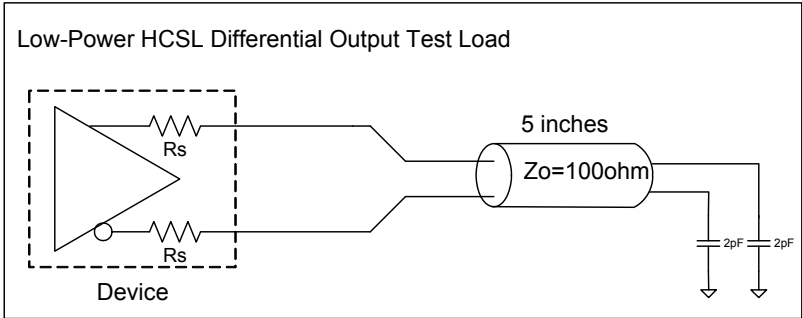
Power Connections

Pin Number		Description
VDD	GND	
3	5,24	XTAL, REF
7	6	Digital Power
11,20	10,21	DIF outputs
16	15	PLL Analog

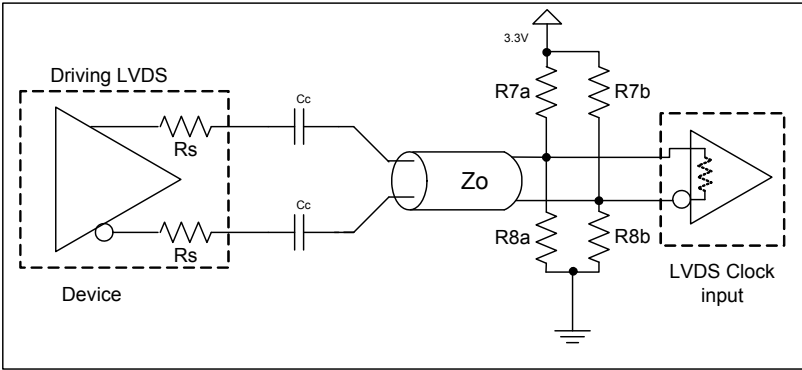
Pin Descriptions

Pin#	Pin Name	Type	Pin Description
1	X1_25	IN	Crystal input, Nominally 25.00MHz.
2	X2	OUT	Crystal output.
3	VDDXTAL1.8	PWR	Power supply for XTAL, nominal 1.8V
4	vSADR/REF1.8	LATCHED I/O	Latch to select SMBus Address/1.8V LVCMOS copy of X1 pin.
5	GNDREF	GND	Ground pin for the REF outputs.
6	GNDDIG	GND	Ground pin for digital circuitry
7	VDDDIG1.8	PWR	1.8V digital power (dirty power)
8	SCLK_3.3	IN	Clock pin of SMBus circuitry, 3.3V tolerant.
9	SDATA_3.3	I/O	Data pin for SMBus circuitry, 3.3V tolerant.
10	GND	GND	Ground pin.
11	VDD1.8	PWR	Power supply, nominal 1.8V
12	vOE0#	IN	Active low input for enabling DIF pair 0. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
13	DIF0	OUT	Differential true clock output
14	DIF0#	OUT	Differential Complementary clock output
15	GND	GND	Ground pin for the PLL core.
16	VDDA1.8	PWR	1.8V power for the PLL core.
17	DIF1	OUT	Differential true clock output
18	DIF1#	OUT	Differential Complementary clock output
19	vOE1#	IN	Active low input for enabling DIF pair 1. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
20	VDD1.8	PWR	Power supply, nominal 1.8V
21	GND	GND	Ground pin.
22	^CKPWRGD_PD#	IN	Input notifies device to sample latched inputs and start up on first high assertion. Low enters Power Down Mode, subsequent high assertions exit Power Down Mode. This pin has internal pull-up resistor.
23	vSS_EN_tri	LATCHED IN	Latched select input to select spread spectrum amount at initial power up : 1 = -0.5% spread, M = -0.25%, 0 = Spread Off
24	GNDXTAL	GND	GND for XTAL

Test Loads



Alternate Terminations



Driving LVDS inputs with the 9FGV0241

Component	Value		Note
	Receiver has termination	Receiver does not have termination	
R7a, R7b	10K ohm	140 ohm	
R8a, R8b	5.6K ohm	75 ohm	
Cc	0.1 uF	0.1 uF	
Vcm	1.2 volts	1.2 volts	

Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the 9FGV0241. These ratings, which are standard values for IDT commercially rated parts, are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
1.8V Supply Voltage	VDDxx	Applies to All VDD pins	-0.5		2.5	V	1,2
Input Voltage	V _{IN}		-0.5		V _{DD} +0.3V	V	1, 3
Input High Voltage, SMBus	V _{IHSMB}	SMBus clock and data pins			3.6V	V	1
Storage Temperature	T _s		-65		150	°C	1
Junction Temperature	T _j				125	°C	1
Input ESD protection	ESD prot	Human Body Model	2000			V	1

¹Guaranteed by design and characterization, not 100% tested in production.

²Operation under these conditions is neither implied nor guaranteed.

³Not to exceed 2.5V.

Electrical Characteristics–Current Consumption

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
Operating Supply Current	I _{DDAOP}	VDDA, PLL Mode, All outputs active @100MHz		7	8	mA	1
	I _{DDOP}	VDD, All outputs active @100MHz		15	18	mA	1
Suspend Supply Current	I _{DDSUSP}	VDDxxx, PD# = 0, Wake-On-LAN enabled		6	8	mA	1
Powerdown Current	I _{DDPD}	PD#=0		0.6	1	mA	1, 2

¹Guaranteed by design and characterization, not 100% tested in production.

²Assuming REF is not running in power down state

Electrical Characteristics–Output Duty Cycle, Jitter, and Skew Characteristics

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
Duty Cycle	t _{DC}	Measured differentially, PLL Mode	45	50	55	%	1
Skew, Output to Output	t _{sk3}	V _T = 50%		34	50	ps	1
Jitter, Cycle to cycle	t _{jcy-cyc}	PLL mode		14	50	ps	1,2

¹Guaranteed by design and characterization, not 100% tested in production.

²Measured from differential waveform

Electrical Characteristics—Input/Supply/Common Parameters—Normal Operating Conditions

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
1.8V Supply Voltage	VDD	Supply voltage for core, analog and single-ended LVCMOS outputs	1.7	1.8	1.9	V	1
Ambient Operating Temperature	T _{COM}	Commercial range	0	25	70	°C	1
	T _{IND}	Industrial range	-40	25	85	°C	1
Input High Voltage	V _{IH}	Single-ended inputs, except SMBus	0.75 V _{DD}		V _{DD} + 0.3	V	1
Input Mid Voltage	V _{IM}	Single-ended tri-level inputs ('_tri' suffix, if present)	0.4 V _{DD}		0.6 V _{DD}	V	1
Input Low Voltage	V _{IL}	Single-ended inputs, except SMBus	-0.3		0.25 V _{DD}	V	1
Schmitt Trigger Positive Going Threshold Voltage	V _{T+}	Single-ended inputs, where indicated	0.4 V _{DD}		0.7 V _{DD}	V	1
Schmitt Trigger Negative Going Threshold Voltage	V _{T-}	Single-ended inputs, where indicated	0.1 V _{DD}		0.4 V _{DD}	V	1
Hysteresis Voltage	V _H	V _{T+} - V _{T-}	0.1 V _{DD}		0.4 V _{DD}	V	1
Output High Voltage	V _{OH}	Single-ended outputs, except SMBus. I _{OH} = -2mA	V _{DD} -0.45			V	1
Output Low Voltage	V _{OL}	Single-ended outputs, except SMBus. I _{OL} = -2mA			0.45	V	1
Input Current	I _{IN}	Single-ended inputs, V _{IN} = GND, V _{IN} = VDD	-5		5	uA	1
	I _{INP}	Single-ended inputs V _{IN} = 0 V; Inputs with internal pull-up resistors V _{IN} = VDD; Inputs with internal pull-down resistors	-200		200	uA	1
Input Frequency	F _{in}	XTAL, or X1 input	23	25	27	MHz	1
Pin Inductance	L _{pin}				7	nH	1
Capacitance	C _{IN}	Logic Inputs, except DIF_IN	1.5		5	pF	1
	C _{OUT}	Output pin capacitance			6	pF	1
Clk Stabilization	T _{STAB}	From V _{DD} Power-Up and after input clock stabilization or de-assertion of PD# to 1st clock		0.4	1.8	ms	1,2
SS Modulation Frequency	f _{MOD}	Allowable Frequency (Triangular Modulation)	31	31.6	32	kHz	1
OE# Latency	t _{LATOE#}	DIF start after OE# assertion DIF stop after OE# deassertion	1	2	3	clocks	1,3
Tdrive_PD#	t _{DRVPD}	DIF output enable after PD# de-assertion			300	us	1,3
Tfall	t _F	Fall time of single-ended control inputs			5	ns	1,2
Trise	t _R	Rise time of single-ended control inputs			5	ns	1,2
SMBus Input Low Voltage	V _{ILSMB}	V _{DDSMB} = 3.3V, see note 4 for V _{DDSMB} < 3.3V			0.8	V	1,4
SMBus Input High Voltage	V _{IHSMB}	V _{DDSMB} = 3.3V, see note 5 for V _{DDSMB} < 3.3V	2.1		3.6	V	1,5
SMBus Output Low Voltage	V _{OLSMB}	@ I _{PULLUP}			0.4	V	1
SMBus Sink Current	I _{PULLUP}	@ V _{OL}	4			mA	1
Nominal Bus Voltage	V _{DDSMB}		1.7		3.6	V	1
SCLK/SDATA Rise Time	t _{RSMB}	(Max V _{IL} - 0.15) to (Min V _{IH} + 0.15)			1000	ns	1
SCLK/SDATA Fall Time	t _{FSMB}	(Min V _{IH} + 0.15) to (Max V _{IL} - 0.15)			300	ns	1
SMBus Operating Frequency	f _{MAXSMB}	Maximum SMBus operating frequency			400	kHz	1

¹ Guaranteed by design and characterization, not 100% tested in production.

² Control input must be monotonic from 20% to 80% of input swing.

³ Time from deassertion until outputs are >200 mV

⁴ For V_{DDSMB} < 3.3V, V_{ILSMB} <= 0.35V_{DDSMB}

⁵ For V_{DDSMB} < 3.3V, V_{IHSMB} >= 0.65V_{DDSMB}

Electrical Characteristics–DIF 0.7V Low Power HCSL Outputs

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
Slew rate	Trf	Scope averaging on 3.0V/ns setting	2	3.1	4.3	V/ns	1, 2, 3
		Scope averaging on 2.0V/ns setting	1.5	2.3	3.5	V/ns	1, 2, 3
Slew rate matching	ΔTrf	Slew rate matching, Scope averaging on		3	20	%	1,2,4
Voltage High	V _{HIGH}	Statistical measurement on single-ended signal using oscilloscope math function. (Scope averaging on)	660	794	850	mV	1,7
Voltage Low	V _{LOW}		-150	21	150		1
Max Voltage	V _{max}	Measurement on single ended signal using absolute value. (Scope averaging off)		816	1150	mV	1
Min Voltage	V _{min}		-300	-15			1
Vswing	Vswing	Scope averaging off	300	1551		mV	1,2
Crossing Voltage (abs)	V _{cross_abs}	Scope averaging off	300	397	550	mV	1,5
Crossing Voltage (var)	Δ-V _{cross}	Scope averaging off		15	140	mV	1,6

¹Guaranteed by design and characterization, not 100% tested in production.

² Measured from differential waveform

³ Slew rate is measured through the Vswing voltage range centered around differential 0V. This results in a +/-150mV window around differential 0V.

⁴ Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a +/-75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations.

⁵ V_{cross} is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e. Clock rising and Clock# falling).

⁶ The total variation of all V_{cross} measurements in any particular system. Note that this is a subset of V_{cross_min/max} (V_{cross} absolute) allowed. The intent is to limit V_{cross} induced modulation by setting Δ-V_{cross} to be smaller than V_{cross} absolute.

⁷ At default SMBus settings.

Electrical Characteristics–Phase Jitter Parameters

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	INDUSTRY LIMIT	UNITS	NOTES
Phase Jitter, PCI Express	t _{jphPCIEG1}	PCIe Gen 1	20	25	35	86	ps (p-p)	1,2,3,5
	t _{jphPCIEG2}	PCIe Gen 2 Lo Band 10kHz < f < 1.5MHz	0.8	0.9	1.1	3	ps (rms)	1,2,5
		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz)	1.5	1.6	1.9	3.1	ps (rms)	1,2,5
	t _{jphPCIEG3}	PCIe Gen 3 (PLL BW of 2-4MHz, CDR = 10MHz)	0.33	0.37	0.50	1	ps (rms)	1,2,4,5

¹ Guaranteed by design and characterization, not 100% tested in production.

² See <http://www.pcisig.com> for complete specs

³ Sample size of at least 100K cycles. This figures extrapolates to 108ps pk-pk @ 1M cycles for a BER of 1-12.

⁴ Calculated from Intel-supplied Clock Jitter Tool

⁵ Applies to all differential outputs

Electrical Characteristics–REF

TA = T_{COM} or T_{IND}; Supply Voltage per VDD of normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	Notes
Long Accuracy	ppm	see Tperiod min-max values		0		ppm	1,2
Clock period	T _{period}	25 MHz output nominal		40		ns	1,2
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 1F, V _{OH} = VDD-0.45V, V _{OL} = 0.45V	0.5	1	2.5	V/ns	1,3
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 5F, V _{OH} = VDD-0.45V, V _{OL} = 0.45V	0.5	1.6	2.5	V/ns	1,3
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 9F, V _{OH} = VDD-0.45V, V _{OL} = 0.45V	0.5	2	2.5	V/ns	1,3
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = DF, V _{OH} = VDD-0.45V, V _{OL} = 0.45V	0.5	2.1	2.5	V/ns	1,3
Duty Cycle	d _{t1}	V _T = VDD/2 V	45	53.1	55	%	1,4
Duty Cycle Distortion	d _{tcd}	V _T = VDD/2 V	0	2	4	%	1,5
Jitter, cycle to cycle	t _{jcyc-cyc}	V _T = VDD/2 V		19	250	ps	1,4
Noise floor	t _{dBc1k}	1kHz offset		-130	-105	dBc	1,4
Noise floor	t _{dBc10k}	10kHz offset to Nyquist		-140	-120	dBc	1,4
Jitter, phase	t _{jphREF}	12kHz to 5MHz		0.63	1.5	ps (rms)	1,4

¹Guaranteed by design and characterization, not 100% tested in production.

²All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REF is trimmed to 25.00 MHz

³Typical value occurs when REF slew rate is set to default value

⁴When driven by a crystal.

⁵When driven by an external oscillator via the X1 pin. X2 should be floating in this case.

Clock Periods–Differential Outputs with Spread Spectrum Disabled

SSC OFF	Center Freq. MHz	Measurement Window							Units	Notes
		1 Clock	1us	0.1s	0.1s	0.1s	1us	1 Clock		
		-c2c jitter AbsPer Min	-SSC Short-Term Average Min	- ppm Long-Term Average Min	0 ppm Period Nominal	+ ppm Long-Term Average Max	+SSC Short-Term Average Max	+c2c jitter AbsPer Max		
DIF	100.00	9.94900		9.99900	10.00000	10.00100		10.05100	ns	1,2

Clock Periods–Differential Outputs with -0.5% Spread Spectrum Enabled

SSC ON	Center Freq. MHz	Measurement Window							Units	Notes
		1 Clock	1us	0.1s	0.1s	0.1s	1us	1 Clock		
		-c2c jitter AbsPer Min	-SSC Short-Term Average Min	- ppm Long-Term Average Min	0 ppm Period Nominal	+ ppm Long-Term Average Max	+SSC Short-Term Average Max	+c2c jitter AbsPer Max		
DIF	99.75	9.94906	9.99906	10.02406	10.02506	10.02607	10.05107	10.10107	ns	1,2

¹Guaranteed by design and characterization, not 100% tested in production.

²All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REF is trimmed to 25.00 MHz

General SMBus Serial Interface Information

How to Write

- Controller (host) sends a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) sends the byte count = X
- IDT clock will **acknowledge**
- Controller (host) starts sending Byte N through Byte N+X-1
- IDT clock will **acknowledge** each byte **one at a time**
- Controller (host) sends a Stop bit

Index Block Write Operation			
Controller (Host)		X Byte	IDT (Slave/Receiver)
T	starT bit		
Slave Address			
WR	WRite		
			ACK
Beginning Byte = N			
			ACK
Data Byte Count = X			
			ACK
Beginning Byte N			
			ACK
O			O
O			O
O			O
			O
Byte N + X - 1			
			ACK
P	stoP bit		

Note: Read/Write address is determined by SADR latch.

How to Read

- Controller (host) will send a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) will send a separate start bit
- Controller (host) sends the read address
- IDT clock will **acknowledge**
- IDT clock will send the data byte count = X
- IDT clock sends Byte N+X-1
- IDT clock sends **Byte 0 through Byte X (if X_(H) was written to Byte 8)**
- Controller (host) will need to acknowledge each byte
- Controller (host) will send a not acknowledge bit
- Controller (host) will send a stop bit

Index Block Read Operation			
Controller (Host)		X Byte	IDT (Slave/Receiver)
T	starT bit		
Slave Address			
WR	WRite		
			ACK
Beginning Byte = N			
			ACK
RT	Repeat starT		
Slave Address			
RD	ReaD		
			ACK
			Data Byte Count=X
ACK			
			Beginning Byte N
ACK			
			O
O			O
O			O
O			
		Byte N + X - 1	
N	Not acknowledge		
P	stoP bit		

SMBus Table: Output Enable Register

Byte 0	Name	Control Function	Type	0	1	Default
Bit 7		Reserved				1
Bit 6		Reserved				1
Bit 5		Reserved				1
Bit 4		Reserved				1
Bit 3		Reserved				1
Bit 2	DIF OE1	Output Enable	RW	Low/Low	Enabled	1
Bit 1	DIF OE0	Output Enable	RW	Low/Low	Enabled	1
Bit 0		Reserved				1

SMBus Table: SS Readback and Vhigh Control Register

Byte 1	Name	Control Function	Type	0	1	Default
Bit 7	SSENRB1	SS Enable Readback Bit1	R	00' for SS_EN_tri = 0, '01' for SS_EN_tri = 'M', '11 for SS_EN_tri = '1'		Latch
Bit 6	SSENRB1	SS Enable Readback Bit0	R			Latch
Bit 5	SSEN_SWCNTRL	Enable SW control of SS	RW	SS control locked	Values in B1[4:3] control SS amount.	0
Bit 4	SSENSW1	SS Enable Software Ctl Bit1	RW ¹	00' = SS Off, '01' = -0.25% SS, '10' = Reserved, '11' = -0.5% SS		0
Bit 3	SSENSW0	SS Enable Software Ctl Bit0	RW ¹			0
Bit 2		Reserved				1
Bit 1	AMPLITUDE 1	Controls Output Amplitude	RW	00 = 0.6V	01 = 0.7V	1
Bit 0	AMPLITUDE 0		RW	10 = 0.8V	11 = 0.9V	0

1. B1[5] must be set to a 1 for these bits to have any effect on the part.

SMBus Table: DIF Slew Rate Control Register

Byte 2	Name	Control Function	Type	0	1	Default
Bit 7		Reserved				1
Bit 6		Reserved				1
Bit 5		Reserved				1
Bit 4		Reserved				1
Bit 3		Reserved				1
Bit 2	SLEWRATESEL DIF1	Adjust Slew Rate of DIF1	RW	2.0V/ns	3.0V/ns	1
Bit 1	SLEWRATESEL DIF0	Adjust Slew Rate of DIF0	RW	2.0V/ns	3.0V/ns	1
Bit 0		Reserved				1

SMBus Table: REF Control Register

Byte 3	Name	Control Function	Type	0	1	Default
Bit 7	REF	Slew Rate Control	RW	00 = Slowest	01 = Slow	0
Bit 6			RW	10 = Fast	11 = Faster	1
Bit 5	REF Power Down Function	Wake-on-Lan Enable for REF	RW	REF does not run in Power Down	REF runs in Power Down	0
Bit 4	REF OE	REF Output Enable	RW	Low	Enabled	1
Bit 3		Reserved				1
Bit 2		Reserved				1
Bit 1		Reserved				1
Bit 0		Reserved				1

Byte 4 is reserved and reads back 'hFF'.

SMBus Table: Revision and Vendor ID Register

Byte 5	Name	Control Function	Type	0	1	Default
Bit 7	RID3	Revision ID	R	A rev = 0000		0
Bit 6	RID2		R			0
Bit 5	RID1		R			0
Bit 4	RID0		R			0
Bit 3	VID3	VENDOR ID	R	0001 = IDT		0
Bit 2	VID2		R			0
Bit 1	VID1		R			0
Bit 0	VID0		R			1

SMBus Table: Device Type/Device ID

Byte 6	Name	Control Function	Type	0	1	Default
Bit 7	Device Type1	Device Type	R	00 = FGV, 01 = DBV, 10 = DMV, 11= Reserved		0
Bit 6	Device Type0		R			0
Bit 5	Device ID5	Device ID	R	00010 binary or 02 hex		0
Bit 4	Device ID4		R			0
Bit 3	Device ID3		R			0
Bit 2	Device ID2		R			0
Bit 1	Device ID1		R			1
Bit 0	Device ID0		R			0

SMBus Table: Byte Count Register

Byte 7	Name	Control Function	Type	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved					0
Bit 5	Reserved					0
Bit 4	BC4	Byte Count Programming	RW	Writing to this register will configure how many bytes will be read back, default is = 8 bytes.		0
Bit 3	BC3		RW			1
Bit 2	BC2		RW			0
Bit 1	BC1		RW			0
Bit 0	BC0		RW			0

Recommended Crystal Characteristics (3225 package)

PARAMETER	VALUE	UNITS	NOTES
Frequency	25	MHz	1
Resonance Mode	Fundamental	-	1
Frequency Tolerance @ 25°C	±20	PPM Max	1
Frequency Stability, ref @ 25°C Over Operating Temperature Range	±20	PPM Max	1
Temperature Range (commercial)	0~70	°C	1
Temperature Range (industrial)	-40~85	°C	2
Equivalent Series Resistance (ESR)	50	Ω Max	1
Shunt Capacitance (C _O)	7	pF Max	1
Load Capacitance (C _L)	8	pF Max	1
Drive Level	0.3	mW Max	1
Aging per year	±5	PPM Max	1

Notes:

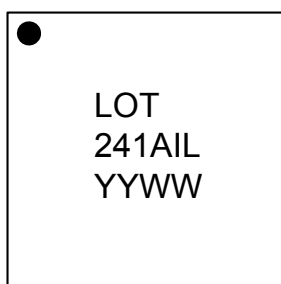
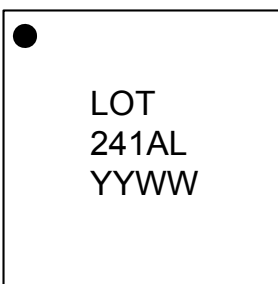
1. IDT 603-25-150JA4C or FOX 603-25-150.
2. For I-temp, IDT 603-25-150JA4I or FOX 603-25-261.

Thermal Characteristics

PARAMETER	SYMBOL	CONDITIONS	PKG	TYP VALUE	UNITS	NOTES
Thermal Resistance	θ_{JC}	Junction to Case	NLG20 NLG24	62	°C/W	1
	θ_{Jb}	Junction to Base		5.4	°C/W	1
	θ_{JA0}	Junction to Air, still air		50	°C/W	1
	θ_{JA1}	Junction to Air, 1 m/s air flow		43	°C/W	1
	θ_{JA3}	Junction to Air, 3 m/s air flow		39	°C/W	1
	θ_{JA5}	Junction to Air, 5 m/s air flow		38	°C/W	1

¹ePad soldered to board

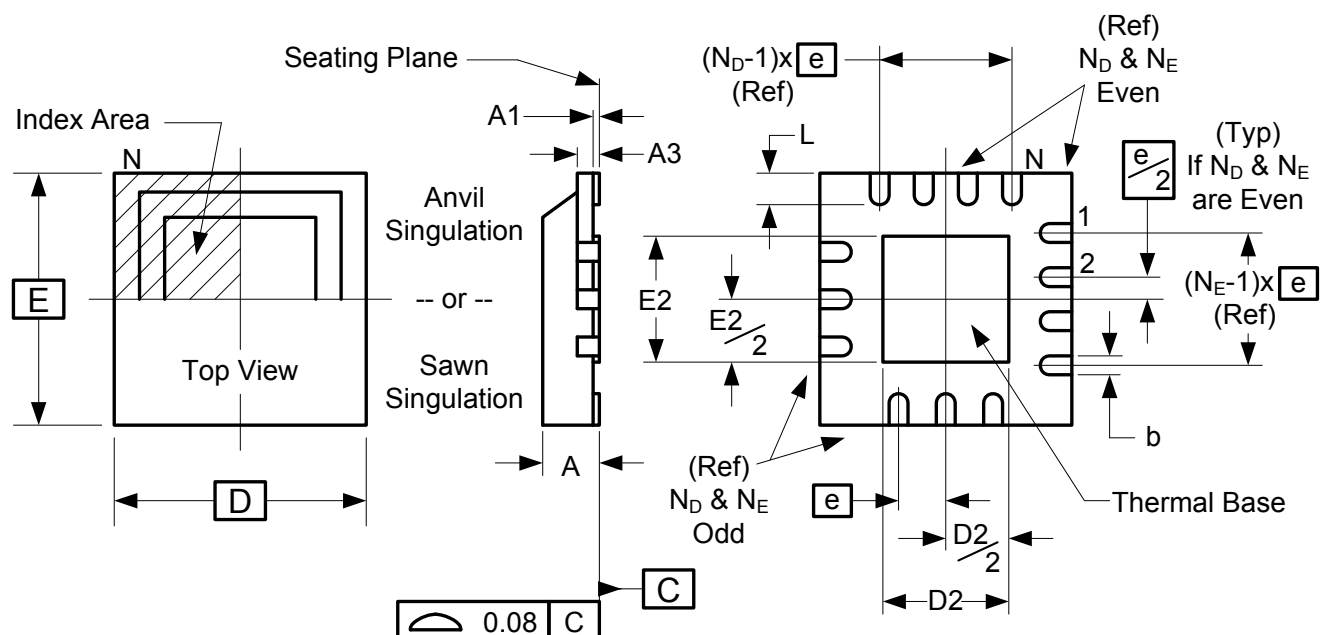
Marking Diagrams



Notes:

1. 'LOT' is the lot number.
2. 'YYWW' is the last two digits of the year and week that the part was assembled.
3. 'L' denotes RoHS compliant package.
4. 'I' denotes industrial temperature grade.

Package Outline and Package Dimensions (NLG24)



Symbol	Millimeters	
	Min	Max
A	0.80	1.00
A1	0	0.05
A3	0.25 Reference	
b	0.18	0.30
e	0.50 BASIC	
D x E BASIC	4.00 x 4.00	
D2 MIN./MAX.	2.3	2.55
E2 MIN./MAX.	2.3	2.55
L MIN./MAX.	0.30	0.50
N	24	
N_D	6	
N_E	6	

Ordering Information

Part / Order Number	Shipping Packaging	Package	Temperature
9FGV0241AKLF	Tubes	24-pin VFQFPN	0 to +70° C
9FGV0241AKLFT	Tape and Reel	24-pin VFQFPN	0 to +70° C
9FGV0241AKILF	Tubes	24-pin VFQFPN	-40 to +85° C
9FGV0241AKILFT	Tape and Reel	24-pin VFQFPN	-40 to +85° C

"LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

"A" is the device revision designator (will not correlate with the datasheet revision).

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Revision History

Rev.	Issue Date	Initiator	Description	Page #
A	8/15/2012	RDW	1. Changed Description, Recommended Application and DS title to say "Clock Generator" instead of "Frequency Generator" 2. Changed Output Features text. Updated block diagram to highlight internal terminations. 3. Highlighted the standby power pins in the pinout (pins 4,5,8) 4. Added footnote 1 to Power Management Table 5. Cleaned up the Test Load Diagrams and merged with Alternate Terminations Diagram. 6. Updated electrical tables with char data, removed "Clock Periods-Single-ended Outputs" table which was redundant. Updated footnote two on Clock Periods Table. 7. Changed integration range for phase jitter calculation of REF from "12kHz to 20MHz" to "12kHz to 5MHz" 8. Corrected Byte 6 9. Added Thermal Data and Recommended Crystal tables 10. Move to final.	1,2,4,5-8,11-13
B	12/19/2012	AT	1. Added SADR column to SMBus Address Selection table. 2. Changed VIH min. from 0.65*VDD to 0.75*VDD, VIM min. from 0.35*VDD to 0.4*VDD and max. from 0.65*VDD to 0.6*VDD, and VIL max. from 0.35*VDD to 0.25*VDD	2,6
C	7/24/2103	RDW	1. Minor updates to electrical characterisitcs per additional char data. 2. Idd reduced for 9FGV0241 3. Slew rate parameters for each setting for REF output added to table. 4. Typical values updated. 5. Changed descriptions of Byte 3, bits 7:6 to "Slowest, Slow, Fast, Faster, since actual values are now included in the REF Electrical Table.	5-8,10
D	9/10/2014	RDW	Updated Ordering Information/Shipping Pacakging from "Trays" to "Tubes".	13
E	2/3/2015	RDW	Updated IDDAOP and IDDOP typ and max specs per latest characterization review.	5
F	11/30/2015	RDW	Updated block diagram	1
F	1/4/2016	RDW	Corrected typo in ordering information; changed rev "B" to rev "A"	13

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